Application/Control No. Applicant(s)/Patent Under Reexamination 10/796,411 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1618 Micah-Paul Young U.S. PATENT DOCUMENTS **Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 01-2000 514/369 US-6,011,049 Whitcomb, Randall Wayne Α * 02-2001 514/440 US-6,191,162 Byrd et al. В С US-US-D Ε US-F US-US-G US-Н US-1 US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS**

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